

Notice of References Cited	Application/Control No. 10/578,528		Applicant(s)/Patent Under Reexamination OZEKI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,135,803 A	11-1938	VICTOR DUMERT	419/66
*	B	US-3,096,248 A	07-1963	RUDZKI HENRYK S	264/112
*	C	US-3,177,077 A	04-1965	MAURICE CHEVRETON et al.	419/2
*	D	US-3,255,278 A	06-1966	SMITH MARK J	264/.5
*	E	US-3,342,915 A	09-1967	WANDERER HERBERT J	264/522
*	F	US-3,571,854 A	03-1971	Lundstrom, Hans	425/77
*	G	US-3,677,673 A	07-1972	Shapiro, Leonard	425/78
*	H	US-4,050,865 A	09-1977	Drosthholm et al.	425/183
*	I	US-4,102,966 A	07-1978	Duperray et al.	264/112
*	J	US-4,390,488 A	06-1983	Wessel, Otto	419/66
*	K	US-4,419,413 A	12-1983	Ebihara, Tadashi	428/548
*	L	US-5,032,335 A	07-1991	Wilson, David	264/113
*	M	US-5,043,123 A	08-1991	Gormanns et al.	264/113

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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NON-PATENT DOCUMENTS

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,088,915 A	02-1992	Korsch et al.	425/345
*	B	US-5,158,728 A	10-1992	Sanderson et al.	264/113
*	C	US-5,160,747 A	11-1992	Kizaki et al.	425/352
*	D	US-5,221,503 A	06-1993	Ward et al.	264/104
*	E	US-5,326,242 A	07-1994	Katagiri et al.	425/78
*	F	US-5,378,416 A	01-1995	Kishi et al.	264/40.5
*	G	US-5,460,827 A	10-1995	Sanderson et al.	424/472
*	H	US-6,068,465 A	05-2000	Wilson, David Henry	425/193
*	I	US-6,423,264 B1	07-2002	Gay, David Earl	264/611
*	J	US-6,602,569 B2	08-2003	Yamashita et al.	428/64.1
*	K	US-2003/0160353 A1	08-2003	Robinson et al.	264/109
*	L	US-2004/0113319 A1	06-2004	Kondo et al.	264/319
*	M	US-2004/0131717 A1	07-2004	Shimada et al.	425/345

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0247728 A1	12-2004	Ozeki, Yuichi	425/354
*	B	US-2005/0013960 A1	01-2005	Ozeki et al.	428/043
*	C	US-6,890,168 B2	05-2005	Kim, Young-Jung	425/78
*	D	US-2005/0220872 A1	10-2005	Ozeki, Yuichi	424/468
*	E	US-7,156,631 B2	01-2007	Ozeki, Yuichi	425/78
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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